

### Fast IGBT in NPT-technology

- 75% lower *E*<sub>off</sub> compared to previous generation combined with low conduction losses
- $\bullet$  Short circuit withstand time 10  $\mu s$
- Designed for:
  - Motor controls
  - Inverter
- NPT-Technology for 600V applications offers:
  - very tight parameter distribution
  - high ruggedness, temperature stable behaviour
     parallel switching capability
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>2</sup> for target applications
- Complete product spectrum and PSpice Models : <u>http://www.infineon.com/igbt/</u>

Туре	V <sub>CE</sub>	I <sub>c</sub>	V <sub>CE(sat)150°C</sub>	Tj	Marking	Package
SGP02N60	600V	2A	2.2V	150°C	G10N60	PG-TO-220-3-1
SGD02N60	600V	2A	2.2V	150°C	G10N60	PG-TO-252-3-11

#### **Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CE</sub>	600	V
DC collector current	I <sub>C</sub>		А
$T_{\rm C} = 25^{\circ}{\rm C}$		6.0	
$T_{\rm C} = 100^{\circ}{\rm C}$		2.9	
Pulsed collector current, $t_p$ limited by $T_{jmax}$	<i>I</i> <sub>Cpuls</sub>	12	
Turn off safe operating area	-	12	
$V_{CE} \le 600 V, \ T_j \le 150^{\circ} C$			
Gate-emitter voltage	V <sub>GE</sub>	±20	V
Avalanche energy, single pulse	E <sub>AS</sub>	13	mJ
$I_{\rm C}$ = 2 A, $V_{\rm CC}$ = 50 V, $R_{\rm GE}$ = 25 $\Omega$ ,			
start at $T_j = 25^{\circ}C$			
Short circuit withstand time <sup>1)</sup>	t <sub>sc</sub>	10	μs
$V_{\text{GE}}$ = 15V, $V_{\text{CC}} \le 600$ V, $T_{j} \le 150^{\circ}$ C			
Power dissipation	P <sub>tot</sub>	30	W
$T_{\rm C} = 25^{\circ}{\rm C}$			
Operating junction and storage temperature	$T_{\rm j}$ , $T_{ m stg}$	-55+150	°C
Soldering temperature,	T <sub>s</sub>	260	
wavesoldering, 1.6mm (0.063 in.) from case for 10s			

<sup>2</sup> J-STD-020 and JESD-022

<sup>1)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.







#### **Thermal Resistance**

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				•
IGBT thermal resistance,	<b>R</b> <sub>thJC</sub>		4.2	K/W
junction – case				
Thermal resistance,	<b>R</b> <sub>thJA</sub>	PG-TO-220-3-1	62	
junction – ambient				
SMD version, device on PCB <sup>1)</sup>	<b>R</b> <sub>thJA</sub>	PG-TO-252-3-1	50	

### **Electrical Characteristic,** at $T_i$ = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value		Unit
Parameter	Symbol	Conditions	min.	Тур.	max.	
Static Characteristic						
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{\rm GE}$ =0V, $I_{\rm C}$ =500 $\mu$ A	600	-	-	V
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	$V_{\rm GE}$ = 15V, $I_{\rm C}$ =2A				
		<i>T</i> <sub>j</sub> =25°C	1.7	1.9	2.4	
		<i>T</i> <sub>j</sub> =150°C	-	2.2	2.7	
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_{\rm C} = 150 \mu {\rm A}, V_{\rm CE} = V_{\rm GE}$	3	4	5	
Zero gate voltage collector current	I <sub>CES</sub>	$V_{\rm CE}$ =600V, $V_{\rm GE}$ =0V				μA
		<i>T</i> <sub>j</sub> =25°C	-	-	20	
		<i>T</i> <sub>j</sub> =150°C	-	-	250	
Gate-emitter leakage current	I <sub>GES</sub>	$V_{\rm CE} = 0  V, V_{\rm GE} = 20  V$	-	-	100	nA
Transconductance	<b>g</b> <sub>fs</sub>	V <sub>CE</sub> =20V, <i>I</i> <sub>C</sub> =2A	-	1.6	-	S
Dynamic Characteristic						
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	142	170	pF
Output capacitance	Coss	V <sub>GE</sub> =0V,	-	18	22	
Reverse transfer capacitance	Crss	f=1MHz	-	10	12	
Gate charge	Q <sub>Gate</sub>	V <sub>CC</sub> =480V, <i>I</i> <sub>C</sub> =2A	-	14	18	nC
		V <sub>GE</sub> =15V				
Internal emitter inductance	L <sub>E</sub>		-	7	-	nH
measured 5mm (0.197 in.) from case						
Short circuit collector current <sup>2)</sup>	I <sub>C(SC)</sub>	$V_{GE}$ =15V, $t_{SC}$ ≤10µs $V_{CC}$ ≤ 600V, $T_{j}$ ≤ 150°C	-	20	-	A

 <sup>&</sup>lt;sup>1)</sup> Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70μm thick) copper area for collector connection. PCB is vertical without blown air.
 <sup>2)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



#### Switching Characteristic, Inductive Load, at Ti=25 °C

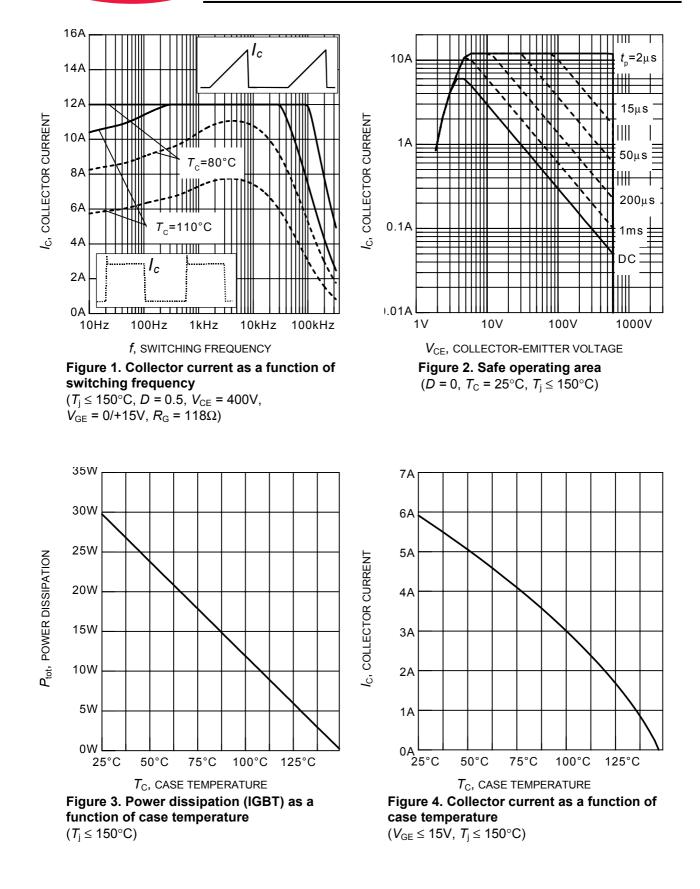
Parameter	Symbol	Conditions		Value		Unit
Farameter	Symbol	Conditions	min.	typ.	max.	
IGBT Characteristic						
Turn-on delay time	t <sub>d(on)</sub>	<i>T</i> <sub>j</sub> =25°C,	-	20	24	ns
Rise time	tr	V <sub>CC</sub> =400V,I <sub>C</sub> =2A, V <sub>GE</sub> =0/15V,	-	13	16	
Turn-off delay time	$t_{d(off)}$	$R_{\rm G}$ =118 $\Omega$ ,	-	259	311	
Fall time	t <sub>f</sub>	$L_{\sigma}^{(1)} = 180 \text{ nH},$	-	52	62	
Turn-on energy	Eon	$C_{\sigma}^{(1)} = 180 \text{ pF}$ Energy losses include	-	0.036	0.041	mJ
Turn-off energy	E <sub>off</sub>	"tail" and diode	-	0.028	0.036	
Total switching energy	Ets	reverse recovery.	-	0.064	0.078	

### Switching Characteristic, Inductive Load, at $T_i$ =150 °C

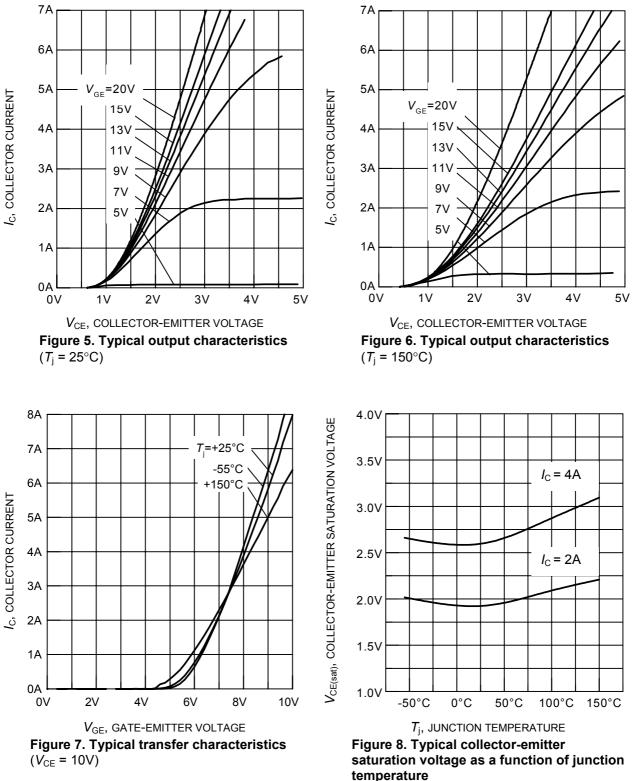
Parameter	Symbol	Conditions	Value			linit
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
IGBT Characteristic						
Turn-on delay time	t <sub>d(on)</sub>	<i>T</i> <sub>j</sub> =150°C,	-	20	24	ns
Rise time	t <sub>r</sub>	V <sub>CC</sub> =400V, <i>I</i> <sub>C</sub> =2A, V <sub>GE</sub> =0/15V,	-	14	17	
Turn-off delay time	$t_{d(off)}$	$R_{\rm G}$ =118 $\Omega$ ,	-	287	344	
Fall time	t <sub>f</sub>	$L_{\sigma}^{(1)} = 180 \text{ nH},$	-	67	80	
Turn-on energy	Eon	$C_{\sigma}^{(1)} = 180 \text{ pF}$ Energy losses include	-	0.054	0.062	mJ
Turn-off energy	E <sub>off</sub>	"tail" and diode	-	0.043	0.056	
Total switching energy	E <sub>ts</sub>	reverse recovery.	-	0.097	0.118	

<sup>1)</sup> Leakage inductance  $L_{\sigma}$  and Stray capacity  $C_{\sigma}$  due to dynamic test circuit in Figure E.



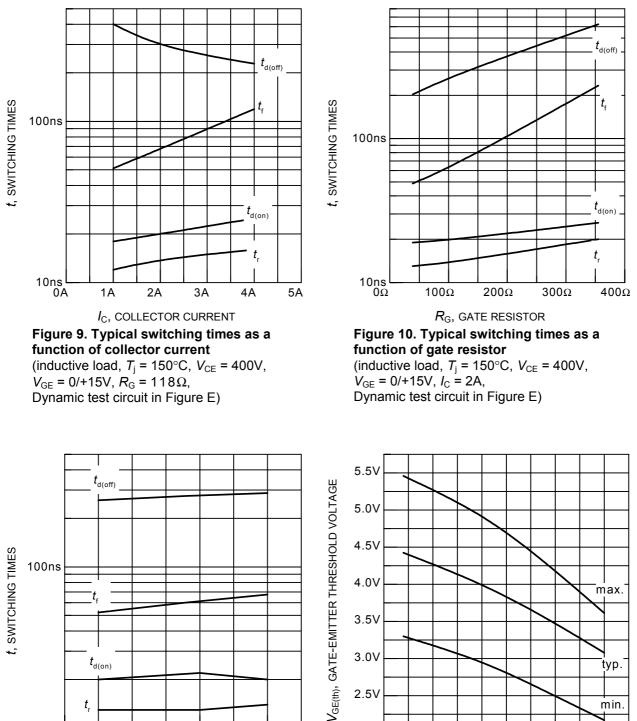


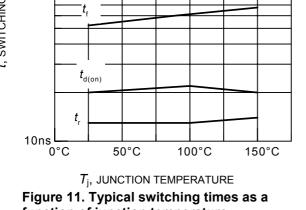




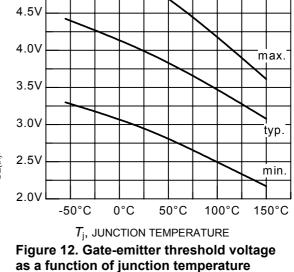
 $(V_{\rm GE} = 15V)$ 





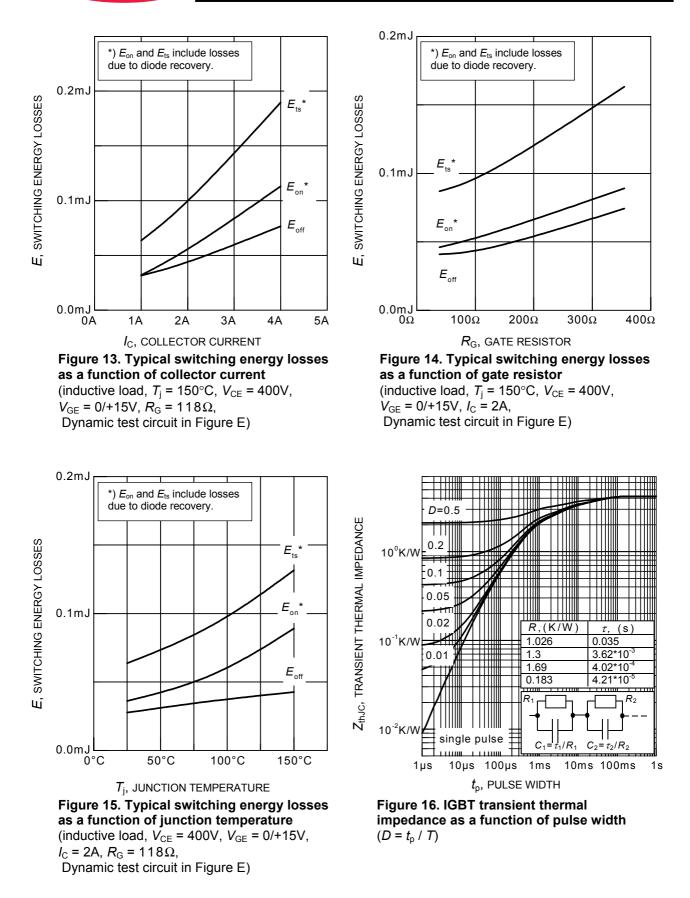


function of junction temperature (inductive load,  $V_{CE} = 400V$ ,  $V_{GE} = 0/+15V$ ,  $I_{\rm C} = 2A, R_{\rm G} = 118\Omega,$ Dynamic test circuit in Figure E)

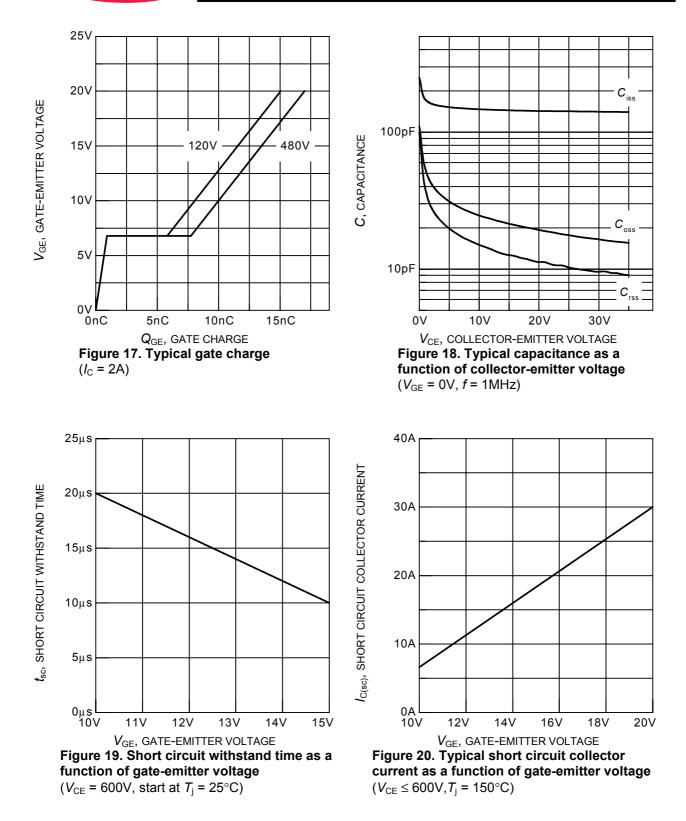


 $(I_{\rm C} = 0.15 {\rm mA})$ 

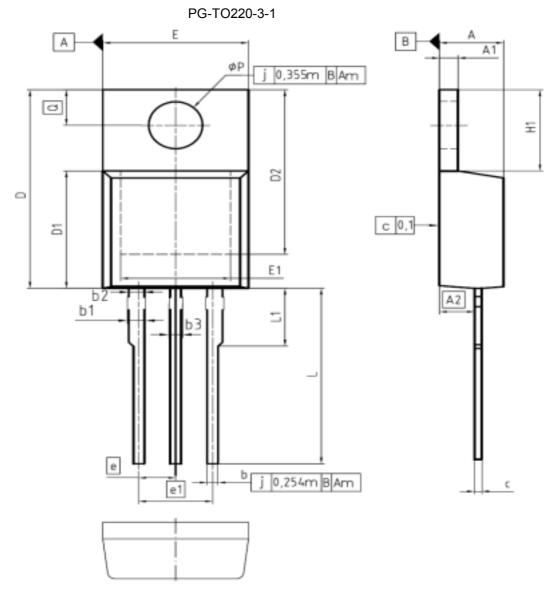




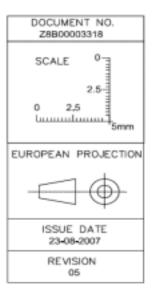




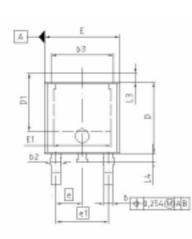


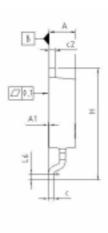


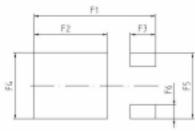
DIM	MILLIM	ETERS	INC	1ES
DIM	MIN	MAX	MIN	MAX
A	4.30	4.57	0.169	0.180
A1	1.17	1.40	0.046	0.055
A2	2.15	2.72	0.085	0.107
ь	0.65	0.86	0,026	0.034
ь1	0.95	1.40	0.037	0.055
ь2	0.95	1.15	0,037	0.045
ь3	0,65	1,15	0,026	0.045
с	0.33	0.60	0.013	0.024
D	14.81	15.95	0.583	0.628
D1	8.51	9.45	0,335	0.372
D2	12.19	13.10	0.480	0.516
E	9.70	10.36	0.382	0.408
E1	6,50	8,60	0,256	0.339
e	2.	54	0.100	
e1	5.	80	0.2	200
N		3	1	3
H1	5.90	6.90	0.232	0.272
L	13.00	14.00	0.512	0.551
L1	-	4.80	-	0.189
øP	3.60	3.89	0.142	0.153
0	2.60	3.00	0.102	0,118









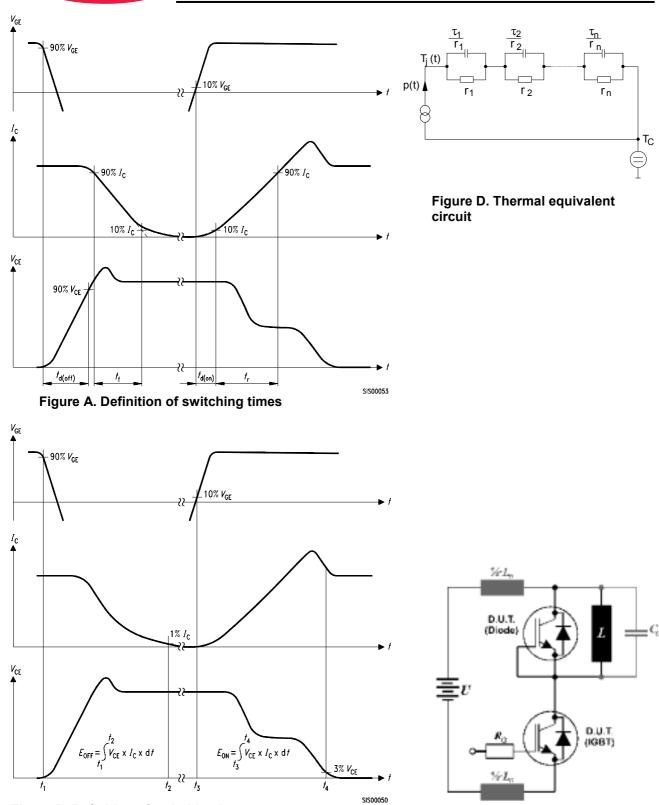


DIM	MILLIM	ETERS	INC	HES	
DIM	MIN	MAX	MIN	MAX	
A	2.184	2.388	0.066	0.094	
A1	0.000	0.150	0.000	0.008	
b	0.635	0.889	0.025	0.035	
b2	0.650	1.150	0.025	0.045	
b3	5,004	5.500	0.197	0.217	
0	0.460	0.580	0.01B	0.023	
62	0.460	0.980	0.018	0.039	
D	5,969	6.223	0.235	0.245	
D1	5.020	5.320	0.196	0.209	
E	6,400	6.731	0.252	0.265	
E1	4.900	5.100	0.193	0.204	
	2.2	86	0.090		
e1	4,5	72	0.1	180	
N	3	1	3		
н	9,400	10.084	0.370	0.397	
L3	0.900	1.118	0.035	0.044	
L4	0.650	1.016	0.026	0.040	
L6	0.510	0.685	0.020	0.027	
F1	10.500	10.700	0.413	0.421	
F2	6.300	6.500	0.248	0.256	
F3	2.100	2.300	0.063	0.091	
F4	5.700	5.900	0.224	0.232	
F5	5.660	5.880	0.222	0.231	
F6	1.100	1.300	0.043	0.051	

PG-TO252-3-11



Figure B. Definition of switching losses



**Figure E. Dynamic test circuit** Leakage inductance  $L_{\sigma}$  =180nH and Stray capacity  $C_{\sigma}$  =180pF.



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